## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination MITCHELL, STEVE Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,415,659	05-1995	Lee et al.	606/61
*	В	US-6,652,527	11-2003	Zucherman et al.	606/61
*	С	US-5,702,452	12-1997	Argenson et al.	606/61
*	D	US-5,702,392	12-1997	Wu et al.	606/61
*	E	US-2002/0040223	04-2002	Sato et al.	606/61
*	F	US-2003/0109882	06-2003	Shirado et al.	606/61
*	G	US-6,589,243	07-2003	Viart et al.	606/61
*	Н	US-5,507,747	04-1996	Yuan et al.	606/61
*	ı	US-4,827,918	05-1989	Olerud, Sven	606/61
*	J	US-4,257,409	03-1981	Bacal et al.	606/61
*	к	US-3,915,160	10-1975	Lode et al.	606/53
*	L	US-5,702,452	12-1997	Argenson et al.	606/61
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
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	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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